

Maximum Ratings @T_A = 25°C unless otherwise specified

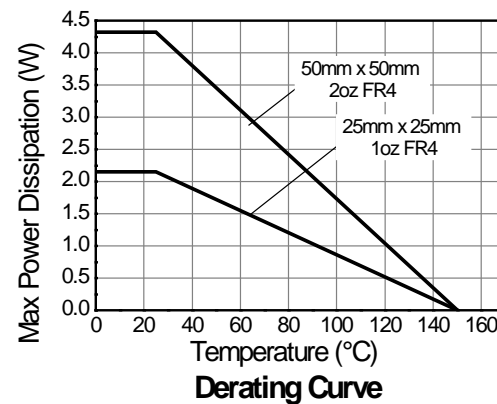
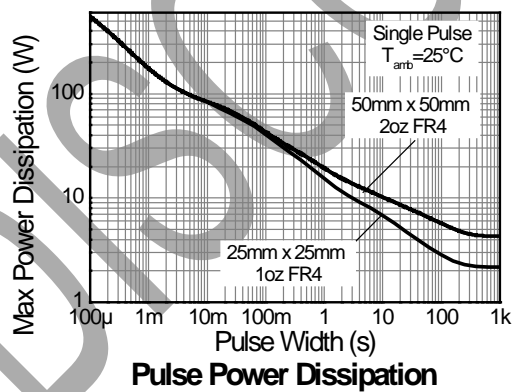
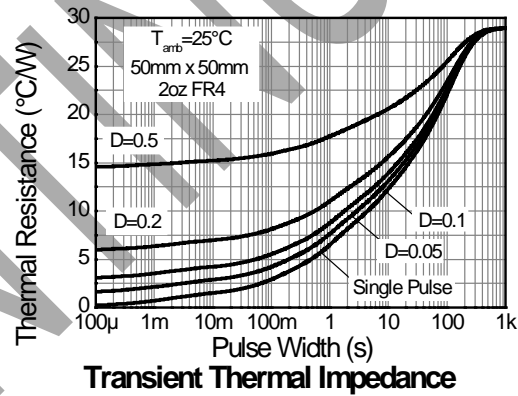
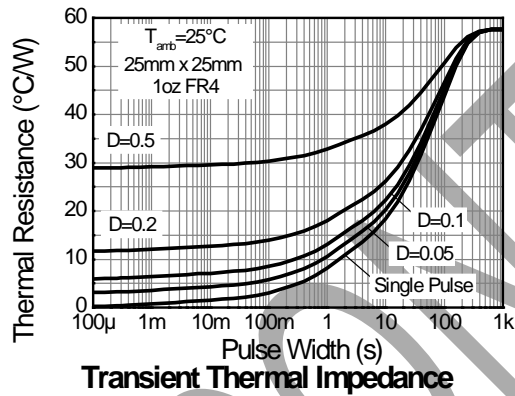
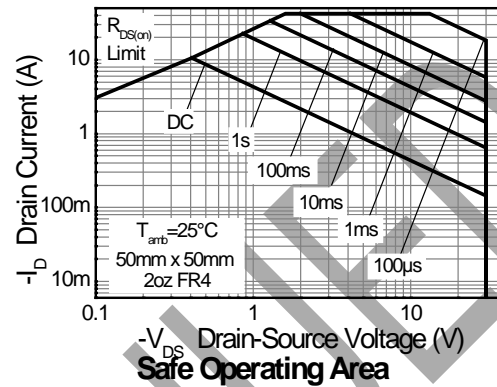
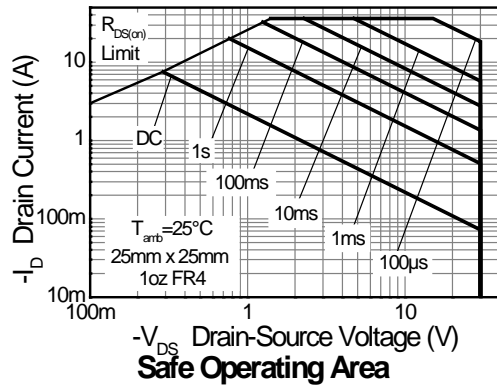
Characteristic			Symbol	Value	Unit
Drain-Source voltage			V _{DSS}	-30	V
Gate-Source voltage			V _{GS}	±20	V
Continuous Drain current	V _{GS} = 10V	(Note 3)	I _D	-16.1	A
		T _A = 70°C (Note 3)		-12.9	
		(Note 2)		-10.6	
Pulsed Drain current	V _{GS} = 10V	(Note 4)	I _{DM}	-41.9	A
Continuous Source current (Body diode)			I _S	-12.6	A
Pulsed Source current (Body diode)			I _{SM}	-41.9	A

Thermal Characteristics @T_A = 25°C unless otherwise specified

Characteristic		Symbol	Value	Unit
Power dissipation Linear derating factor	(Note 2)	P _D	4.3	W mW/°C
	(Note 3)		34.5	
	(Note 3)		10.0	
	(Note 5)		80.0	
Thermal Resistance, Junction to Ambient	(Note 2)	R _{θJA}	2.15	°C/W
	(Note 3)		17.2	
	(Note 5)		29.0	
Thermal Resistance, Junction to Lead	(Note 3)	R _{θJA}	12.5	°C/W
	(Note 5)		58.0	
	(Note 6)		1.02	
Operating and storage temperature range		T _J , T _{STG}	-55 to 150	°C

- Notes:
2. For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
 3. Same as note 2, except the device is measured at t ≤ 10 sec.
 4. Same as note 2, except the device is pulsed with D = 0.02 and pulse width 300 μs. The pulse current is limited by the maximum junction temperature.
 5. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
 6. Thermal resistance from junction to solder-point (at the end of the drain lead).

Thermal Characteristics

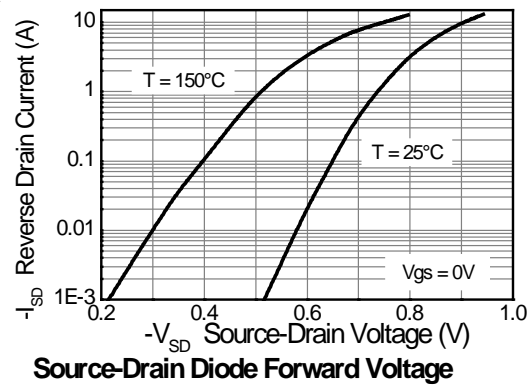
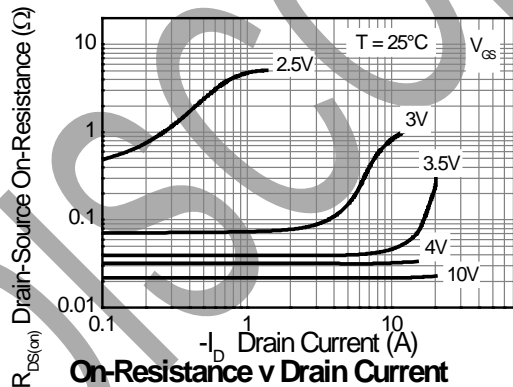
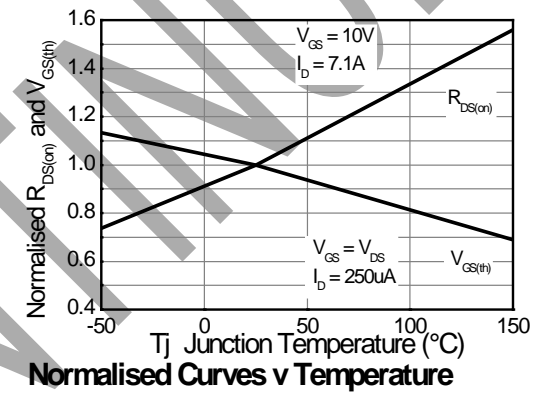
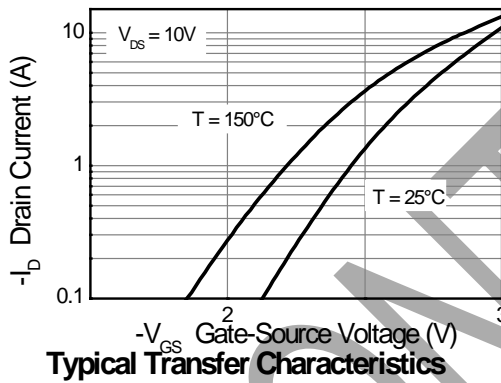
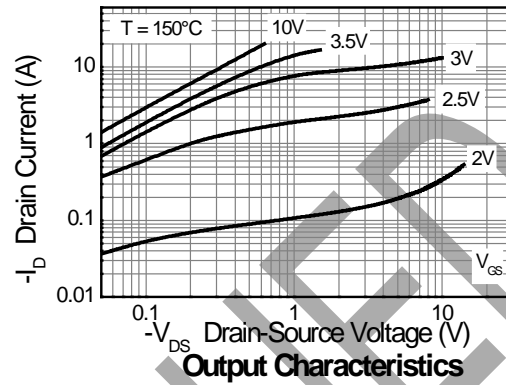
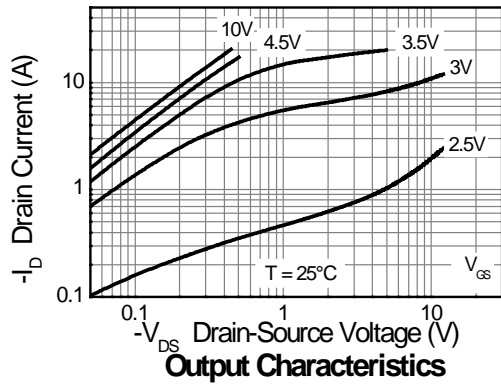


Electrical Characteristics @T_A = 25°C unless otherwise specified

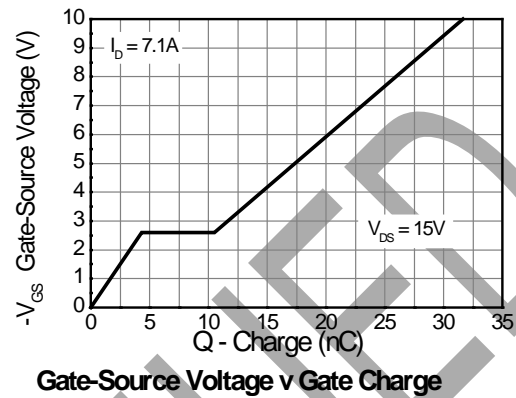
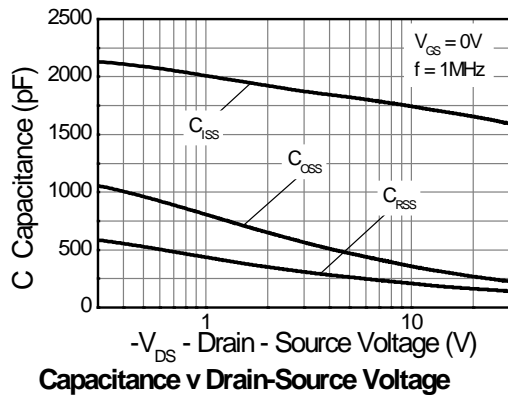
Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition	
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV _{DSS}	-30	—	—	V	I _D = -250μA, V _{GS} = 0V	
Zero Gate Voltage Drain Current	I _{DSS}	—	—	-0.5	μA	V _{DS} = -30V, V _{GS} = 0V	
Gate-Source Leakage	I _{GSS}	—	—	±100	nA	V _{GS} = ±20V, V _{DS} = 0V	
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(th)}	-1.0	—	-3.0	V	I _D = -250μA, V _{DS} = V _{GS}	
Static Drain-Source On-Resistance (Note 7)	R _{DS (ON)}	—	—	0.025	•	V _{GS} = -10V, I _D = -7.1A	
				0.041		V _{GS} = -4.5V, I _D = -5.5A	
Forward Transconductance (Notes 7 & 8)	g _{fs}	—	18.6	—	S	V _{DS} = -15V, I _D = -7.1A	
Diode Forward Voltage (Note 7)	V _{SD}	—	-0.80	-1.2	V	I _S = -1.7A, V _{GS} = 0V	
Reverse recovery time (Note 8)	t _{rr}	—	16.2	—	ns	I _S = -2.2A, di/dt= 100A/μs	
Reverse recovery charge (Note 8)	Q _{rr}	—	10	—	nC		
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C _{iss}	—	1678	—	pF	V _{DS} = -15V, V _{GS} = 0V f= 1MHz	
Output Capacitance	C _{oss}	—	303	—	pF		
Reverse Transfer Capacitance	C _{rss}	—	178	—	pF		
Total Gate Charge	Q _g	—	16.5	—	nC	V _{GS} = -4.5V	V _{DS} = -15V, I _D = -7.1A
Total Gate Charge	Q _g	—	31.6	—	nC	V _{GS} = -10V	
Gate-Source Charge	Q _{gs}	—	4.3	—	nC		
Gate-Drain Charge	Q _{gd}	—	6.2	—	nC		
Turn-On Delay Time (Note 9)	t _{D(on)}	—	3.5	—	ns	V _{DD} = -15V, V _{GS} = -10V I _D = -1A, R _G ≅ 6.0Ω	
Turn-On Rise Time (Note 9)	t _r	—	4.9	—	ns		
Turn-Off Delay Time (Note 9)	t _{D(off)}	—	44	—	ns		
Turn-Off Fall Time (Note 9)	t _f	—	23	—	ns		

- Notes:
7. Measured under pulsed conditions. Pulse width ≤ 300μs; duty cycle ≤ 2%
 8. For design aid only, not subject to production testing.
 9. Switching characteristics are independent of operating junction temperatures.

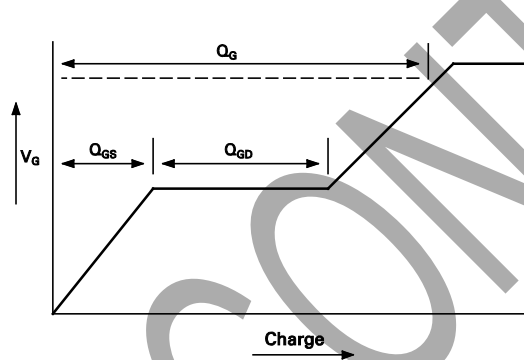
Typical Characteristics



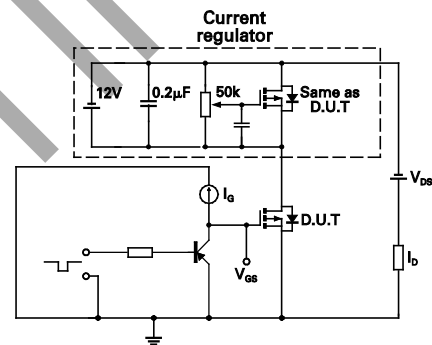
Typical Characteristics - continued



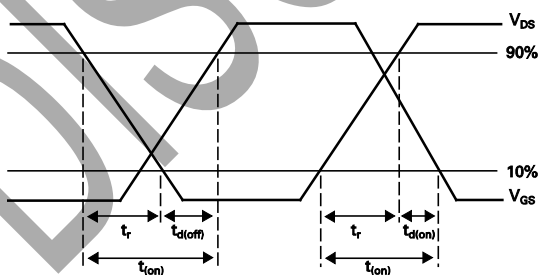
Test Circuits



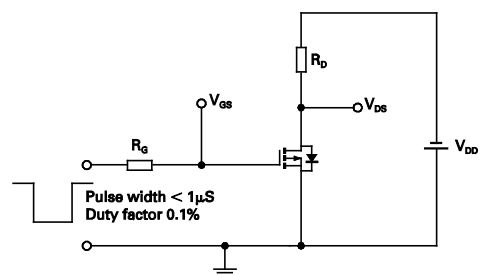
Basic gate charge waveform



Gate charge test circuit

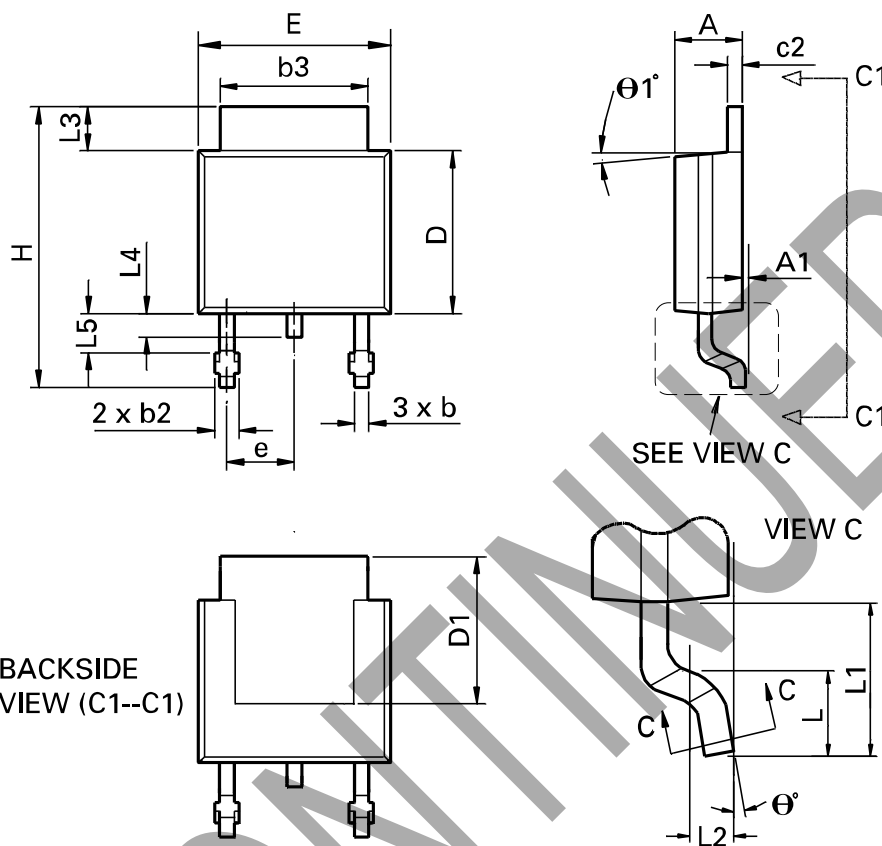


Switching time waveforms



Switching time test circuit

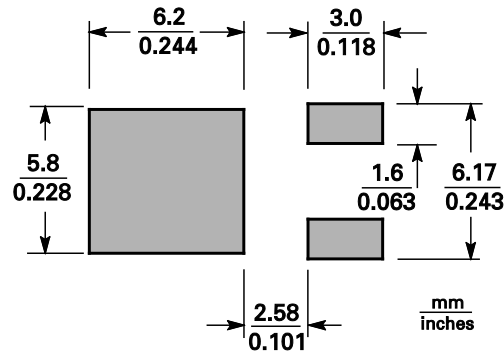
Package Outline Dimensions



BACKSIDE
VIEW (C1--C1)

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min	Max	Min	Max		Min	Max	Min	Max
A	0.086	0.094	2.18	2.39	e	0.090 BSC		2.29 BSC	
A1	-	0.005	-	0.127	H	0.370	0.410	9.40	10.41
b	0.020	0.035	0.508	0.89	L	0.055	0.070	1.40	1.78
b2	0.030	0.045	0.762	1.14	L1	0.108 REF		2.74 REF	
b3	0.205	0.215	5.21	5.46	L2	0.020 BSC		0.508 BSC	
c	0.018	0.024	0.457	0.61	L3	0.035	0.065	0.89	1.65
c2	0.018	0.023	0.457	0.584	L4	0.025	0.040	0.635	1.016
D	0.213	0.245	5.41	6.22	L5	0.045	0.060	1.14	1.52
D1	0.205	-	5.21	-	$\bullet 1^\circ$	0°	10°	0°	10°
E	0.250	0.265	6.35	6.73	\bullet°	0°	15°	0°	15°
E1	0.170	-	4.32	-	-	-	-	-	-

Suggested Pad Layout



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